

**UNIVERSITY OF CALIFORNIA, MERCED**

**SCIF CLEANROOM FACILITY**

**STANDARD OPERATING PROCEDURE (SOP)**

**RF Magnetron Sputtering System Operation (VTC-1RF / RF-300I or Equivalent)**

**Location:** SE1: 154, Class 1000 Cleanroom

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## **1. PURPOSE**

To provide a detailed, standardized, and safe procedure for thin film deposition using RF magnetron sputtering, ensuring reproducibility, equipment protection, and user safety.

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## **2. SCOPE**

Applicable to all trained users performing thin film deposition using RF sputtering systems for metals, oxides, and dielectric materials.

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## **3. RESPONSIBILITIES**

- **Users:** Follow SOP and ensure proper parameters
  - **Core Staff:** Maintain system and provide training
  - **Facility:** Ensure utilities, safety, and compliance
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## **4. SYSTEM OVERVIEW**

RF sputtering uses plasma (typically Ar gas) to eject atoms from a target, depositing them onto a substrate.

### **Capabilities:**

- Thin film deposition (nm– $\mu\text{m}$  scale)
  - Oxide and dielectric materials (RF mode)
  - Metal coating (RF/DC depending system)
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## 5. REQUIRED SYSTEM CONDITIONS

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### 5.1 Utilities

- Argon gas ( $\geq 99.999\%$  purity recommended)
  - Vacuum pump operational ( $10^{-3}$  to  $10^{-6}$  Torr range)
  - Water cooling active (for sputtering head)
  - RF power generator (13.56 MHz, up to  $\sim 300\text{W}$ )
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### 5.2 System Conditions

- Chamber clean and sealed
  - Target installed correctly
  - No vacuum leaks
  - Thickness monitor operational (if available)
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## 6. SAFETY REQUIREMENTS

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### 6.1 Hazards

- High voltage RF power
  - Plasma radiation
  - Vacuum implosion risk
  - Pressurized gas cylinders
  - Thermal heating (substrate up to  $\sim 700^\circ\text{C}$  possible)
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### 6.2 PPE

- Cleanroom gloves
- Safety glasses

- Lab coat
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### **6.3 Critical Safety Rules**

- Never exceed gas pressure limits (<3 PSI input)
  - Never operate without cooling
  - Do not use flammable gases
  - Ensure proper grounding
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## **7. DETAILED OPERATION PROCEDURE**

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### **STEP 1: SYSTEM PRE-CHECK**

- Verify:
  - Pump oil level
  - Cooling water level
  - Target installed correctly
  - Chamber clean

👉 Manual confirms pump oil and water level must be checked before operation

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### **STEP 2: LOAD SAMPLE**

- Open chamber
  - Place substrate on holder
  - Ensure:
    - Clean surface
    - Proper positioning
  - Close and seal chamber
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### STEP 3: START UTILITIES

- Turn ON:
    - Water chiller
    - Vacuum pump
    - Main system power
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### STEP 4: PUMP DOWN

- Evacuate chamber
- Target:
  - ~1 Pa initial vacuum check
- Verify:
  - No leaks
  - Stable pressure

👉 Manual indicates ~1 Pa confirms good sealing

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### STEP 5: ARGON GAS INTRODUCTION (PURGE)

- Open Ar gas
- Increase pressure to ~100–120 Pa
- Purge chamber (~5 minutes)

Then reduce pressure to:

- ~10 Pa (working pressure)

👉 This purge + working pressure sequence is critical for clean plasma

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### STEP 6: SET PROCESS PARAMETERS

- RF Power:
  - Start ~30 W

- Pressure:
    - ~10 Pa
  - Rotation:
    - 1–10 rpm
  - Optional:
    - Substrate heating
    - Thickness monitor setup
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### **STEP 7: IGNITE PLASMA**

- Turn ON RF generator
- Enable output
- Adjust matching network

👉 RF must be matched ( $P_r \approx 0$ ) for stable plasma

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### **STEP 8: PRE-SPUTTER (TARGET CLEANING)**

- Block substrate (use shutter)
- Run plasma for ~2–3 minutes

👉 Removes contamination from target surface

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### **STEP 9: DEPOSITION**

- Open shutter
- Begin deposition
- Monitor:
  - Plasma stability
  - Pressure
  - Power

- Adjust:
    - RF power
    - Gas flow
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### **STEP 10: MONITOR FILM GROWTH**

- If thickness monitor available:
  - Set material density
  - Monitor rate

👉 Thickness depends on current, time, and material constant

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### **STEP 11: COMPLETE DEPOSITION**

- Close shutter
  - Reduce RF power gradually
  - Turn OFF RF
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### **STEP 12: SHUTDOWN**

- Turn OFF:
    - Gas flow
    - Pump
    - Cooling
  - Vent chamber slowly
  - Remove sample
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## **8. TROUBLESHOOTING GUIDE**

<b>Issue</b>	<b>Cause</b>	<b>Action</b>
No plasma	Low pressure / mismatch	Adjust gas & match
Arcing	Contamination	Clean chamber
Low deposition rate	Low power	Increase RF
Non-uniform film	No rotation	Enable rotation
Poor adhesion	Dirty substrate	Improve cleaning

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## **9. CRITICAL DOs & DON'Ts**

### **DO**

- Pre-sputter before deposition
  - Use high-purity Ar gas
  - Maintain clean chamber
  - Monitor pressure continuously
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### **DON'T**

- Run at high power for long duration
  - Use contaminated targets
  - Skip purge step
  - Operate without cooling
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## **10. CONTAMINATION CONTROL**

- Clean chamber regularly
- Avoid introducing dust/oils
- Clean substrate before deposition
- Store targets properly

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## 11. WASTE HANDLING

- Dispose wipes and residues properly
- Follow SCIF hazardous waste procedures

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## 12. EMERGENCY PROCEDURES

- Power issue → Shut OFF immediately
- Vacuum failure → Stop process
- Gas leak → Close cylinder
- Plasma instability → Turn OFF RF

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## 13. TRAINING COVERAGE

Users are trained on:

- Plasma physics basics
- RF power and matching
- Target handling
- Deposition parameter control
- Thickness monitoring
- Safety procedures

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## 14. ACKNOWLEDGMENT & APPROVAL

**Director Name:** \_\_\_\_\_

**Director Signature:** \_\_\_\_\_

**Date:** \_\_\_\_\_

**User Name:** \_\_\_\_\_

**User Signature:** \_\_\_\_\_

**Date:** \_\_\_\_\_

